

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/664,671	INOUE ET AL.	
Examiner	Art Unit	
Shean C. Wu	1756	

SEARCHED				
Class	Subclass	Date	Examiner	
			. <u>.</u> .	
!				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
-	DATE	EXMR
update CAS on line structure serach, see attachment	7/17/2006	SW